

# Search Notes



Application No.

10/811,822

Examiner

Sang Y Paik

Applicant(s)

TOYA ET AL.

Art Unit

3742

## SEARCHED

Class	Subclass	Date	Examiner
392	386		
	391		
	396		
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219	344		
	346		
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	348		
	349		
1/27/05 JP			

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EARLY TEST JEPANGS	1/27/05	JP